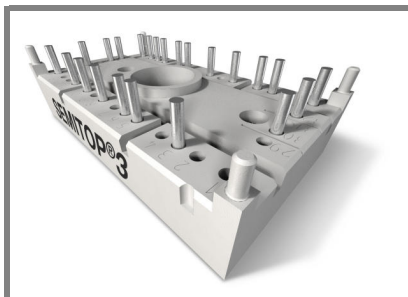


# SK50GB067



SEMITOP® 3

## IGBT Module

SK50GB067

SK50GAL067

SK50GAR067

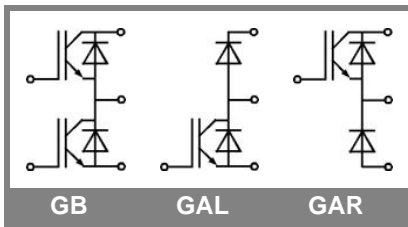
Target Data

### Features

- Compact design
- One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- Hyperfast NPT technology IGBT
- N-channel homogeneous silicon structure (NPT Non-Punch-Through IGBT)
- Positive  $V_{ce,sat}$  temperature coefficient (Easy paralleling)
- Low tail current with low temperature dependence
- Low threshold voltage

### Typical Applications

- Switching (not for linear use)
- High Frequencies Applications
- Welding generator
- Switched mode power supplies
- UPS



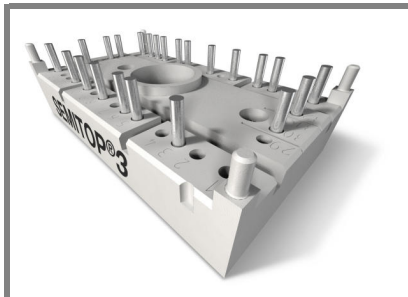
Absolute Maximum Ratings		$T_s = 25^\circ\text{C}$ , unless otherwise specified	
Symbol	Conditions	Values	Units
<b>IGBT</b>			
$V_{CES}$	$T_j = 25^\circ\text{C}$	600	V
$I_C$	$T_j = 125^\circ\text{C}$	$T_s = 25^\circ\text{C}$	83 A
		$T_s = 80^\circ\text{C}$	54 A
$I_{CRM}$	$I_{CRM} = 2 \times I_{Cnom}$	240	A
$V_{GES}$		$\pm 20$	V
$t_{psc}$	$V_{CC} = 300\text{ V}; V_{GE} \leq 20\text{ V}; T_j = 125^\circ\text{C}$ $V_{CES} < 600\text{ V}$	10	$\mu\text{s}$

Inverse Diode		$T_s = 25^\circ\text{C}$ , unless otherwise specified	
Symbol	Conditions	Values	Units
$I_F$	$T_j = 150^\circ\text{C}$	$T_s = 25^\circ\text{C}$	90 A
		$T_s = 80^\circ\text{C}$	56 A
$I_{FRM}$	$I_{FRM} = 2 \times I_{Fnom}$		A
$I_{FSM}$	$t_p = 10\text{ ms}; \text{ sinusoidal}$	$T_j = 25^\circ\text{C}$	360 A

Freewheeling Diode		$T_s = 25^\circ\text{C}$ , unless otherwise specified	
Symbol	Conditions	Values	Units
$I_F$	$T_j = 150^\circ\text{C}$	$T_s = 25^\circ\text{C}$	90 A
		$T_s = 80^\circ\text{C}$	56 A
$I_{FRM}$			A
$I_{FSM}$	$t_p = \text{ms};$	$T_j = 25^\circ\text{C}$	360 A

Module		$T_s = 25^\circ\text{C}$ , unless otherwise specified	
Symbol	Conditions	Values	Units
$I_{t(RMS)}$			A
$T_{vj}$		-40 ... +150	$^\circ\text{C}$
$T_{stg}$		-40 ... +125	$^\circ\text{C}$
$V_{isol}$	AC, 1 min.	2500	V

Characteristics		$T_s = 25^\circ\text{C}$ , unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
<b>IGBT</b>					
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 1,2\text{ mA}$	3	4	5	V
$I_{CES}$	$V_{GE} = 0\text{ V}, V_{CE} = V_{CES}$			0,008	mA
$I_{GES}$	$V_{CE} = 0\text{ V}, V_{GE} = 20\text{ V}$			480	nA
$V_{CE0}$				2	V
$r_{CE}$	$V_{GE} = 15\text{ V}$		12,5		$\text{m}\Omega$
$V_{CE(sat)}$	$I_{Cnom} = 120\text{ A}, V_{GE} = 15\text{ V}$	$T_j = 25^\circ\text{C}_{chiplev.}$	2,8	3,15	V
		$T_j = 125^\circ\text{C}_{chiplev.}$	3,5	4	V
$C_{res}$	$V_{CE} = 25, V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	6		nF
$C_{oes}$			0,6		nF
$C_{res}$			0,36		nF
$t_{d(on)}$	$R_{Gon} = 0\ \Omega$	$V_{CC} = 400\text{ V}$	38		ns
$t_r$			31		ns
$E_{on}$	$R_{Goff} = 11\ \Omega$	$T_j = 125^\circ\text{C}$	7,5		mJ
$t_{d(off)}$			260		ns
$t_f$			30		ns
$E_{off}$		$V_{GE} = \pm 15\text{ V}$	2,5		mJ
$R_{th(j-s)}$	per IGBT			0,45	K/W



**SEMITOP® 3**

## IGBT Module

**SK50GB067**

**SK50GAL067**

**SK50GAR067**

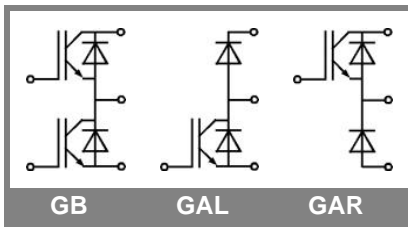
Target Data

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- Low threshold voltage

### Typical Applications

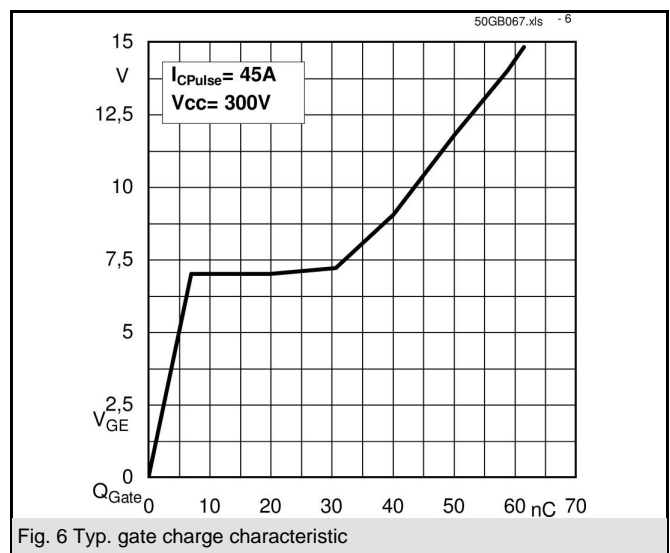
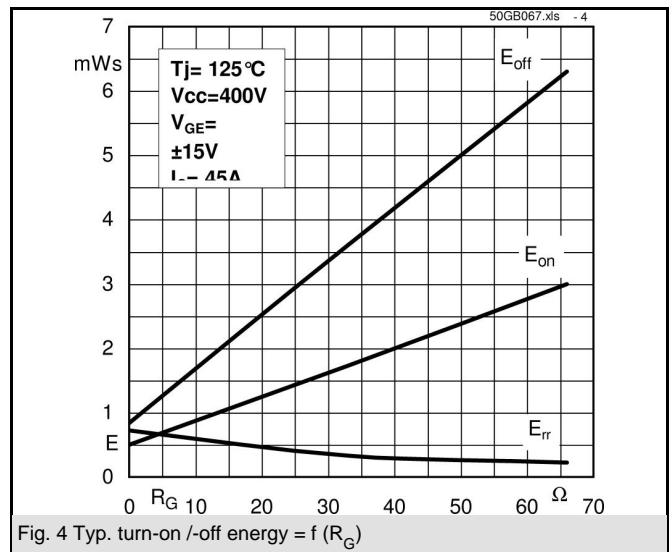
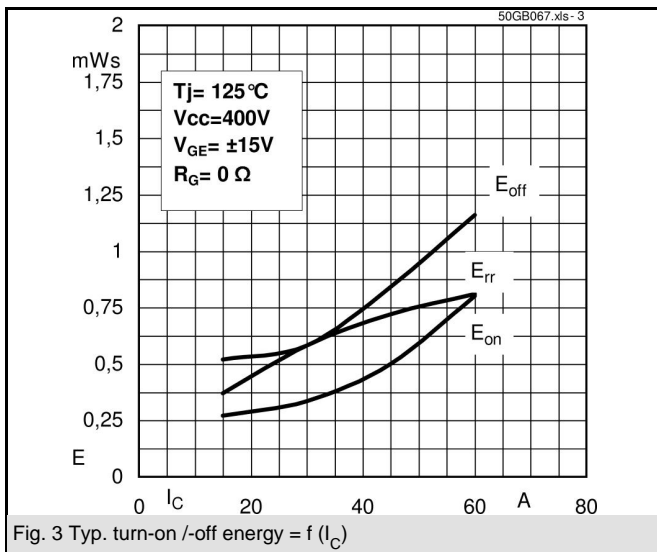
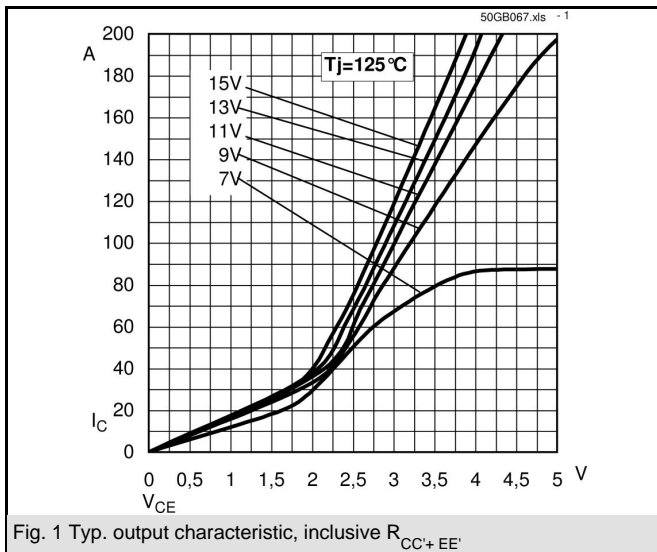
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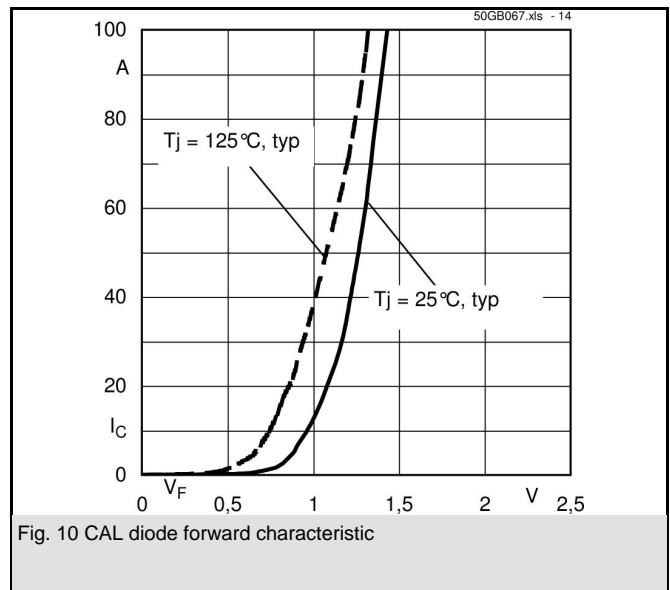
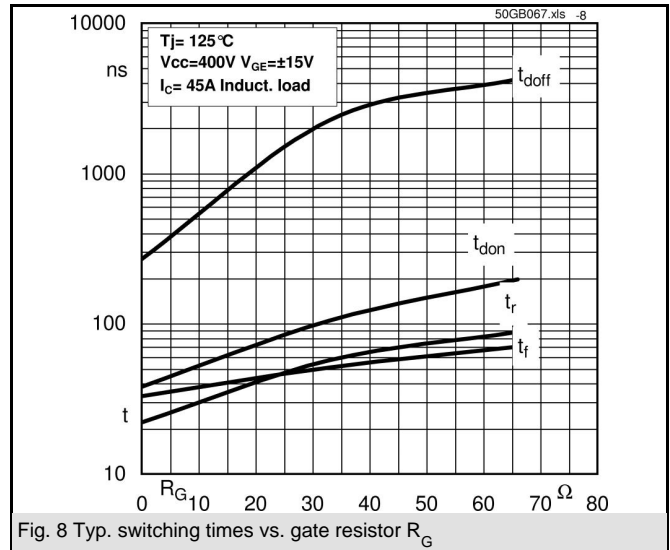
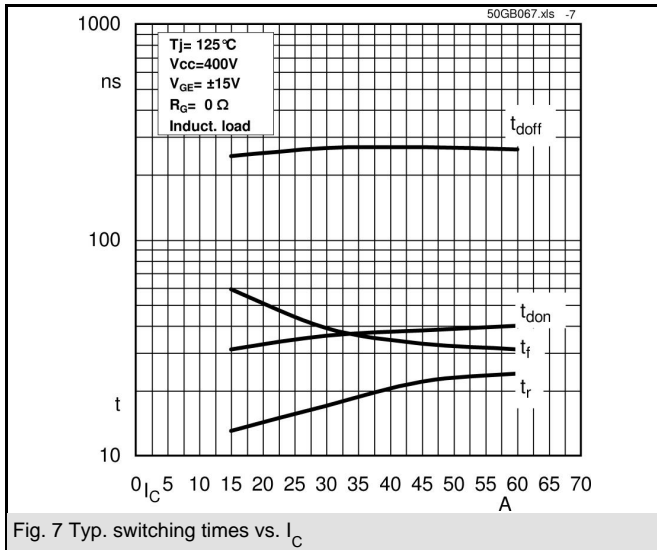


Characteristics				
Symbol	Conditions	min.	typ.	max.   Units
<b>Inverse Diode</b>				
$V_F = V_{EC}$	$I_{Fnom} = 120 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}_{chiplev.}$		2   V
		$T_j = 150 \text{ }^\circ\text{C}_{chiplev.}$	1,25	V
$V_{F0}$		$T_j = 25 \text{ }^\circ\text{C}$		V
		$T_j = 150 \text{ }^\circ\text{C}$	1	V
$r_F$		$T_j = 25 \text{ }^\circ\text{C}$		mΩ
		$T_j = 150 \text{ }^\circ\text{C}$	4	mΩ
$I_{RRM}$	$I_F = 120 \text{ A}$	$T_j = 125 \text{ }^\circ\text{C}$	10	A
$Q_{rr}$	$di/dt = -100 \text{ A}/\mu\text{s}$		8	μC
$E_{rr}$	$V_{CC} = 400\text{V}$		1,6	mJ
$R_{th(j-s)D}$	per diode			0,8   K/W
<b>Free-wheeling diode</b>				
$V_F = V_{EC}$	$I_{Fnom} = 120 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}_{chiplev.}$		2   V
		$T_j = 150 \text{ }^\circ\text{C}_{chiplev.}$	1,25	V
$V_{F0}$		$T_j = 25 \text{ }^\circ\text{C}$		V
		$T_j = 150 \text{ }^\circ\text{C}$	1	V
$r_F$		$T_j = 25 \text{ }^\circ\text{C}$		V
		$T_j = 150 \text{ }^\circ\text{C}$	4	V
$I_{RRM}$	$I_F = 120 \text{ A}$	$T_j = 125 \text{ }^\circ\text{C}$	10	A
$Q_{rr}$			8	μC
$E_{rr}$			1,6	mJ
$R_{th(j-s)FD}$	per diode			0,8   K/W
$M_s$	to heat sink		2,25	2,5   Nm
w			29	g

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.

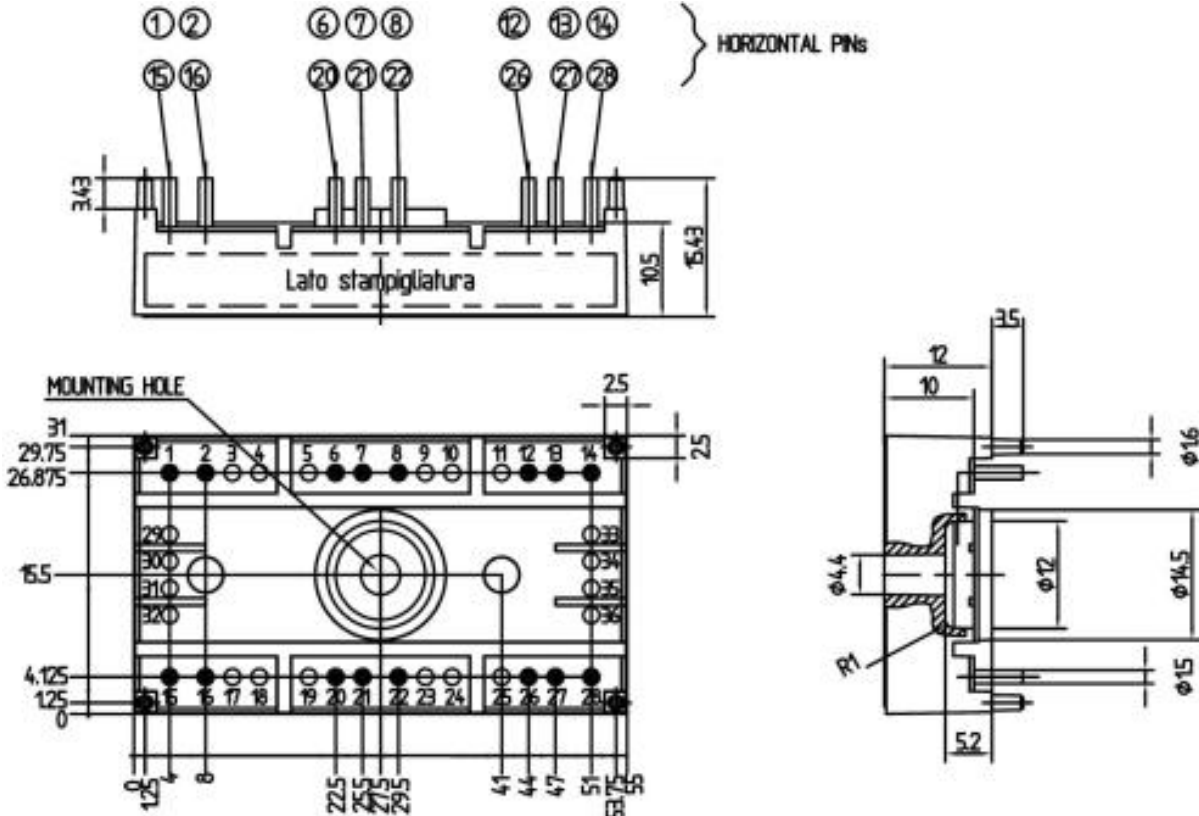




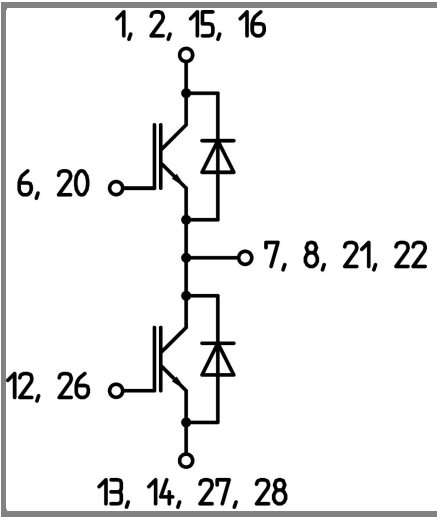
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UL recognized file

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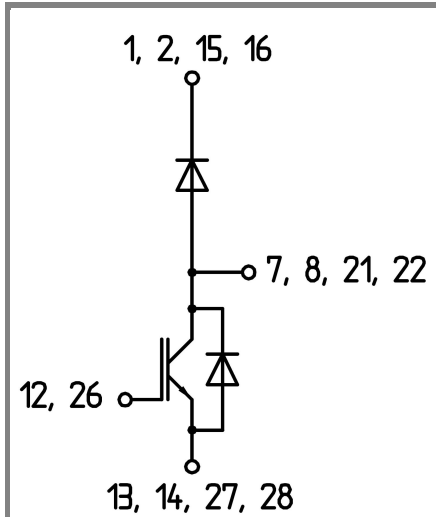


Case T66 (Suggested hole diameter, in the PCB, for solder pins and plastic mounting pins: 2mm)



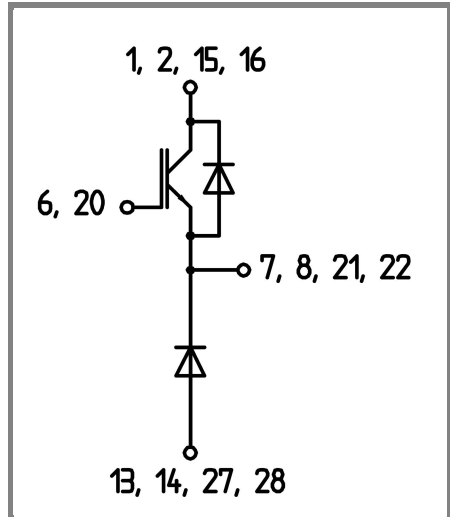
Case T 66

GB



Case T 66

GAL



Case T 66

GAR